



TEST REPORT

No. 23T04Z80808-01

for

Baicells Technologies Co., Ltd.

5G Outdoor CPE

Model Name: SRT853L

FCC ID: 2AG32SRT853L

with

Hardware Version: SRT853L_PCB_V1.00

Software Version: SRT853L_8.0.6_EQ100

Issued Date: 2024-04-23

Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of CTTL.

Test Laboratory:

CTTL-Telecommunication Technology Labs, CAICT

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REPORT HISTORY

Report Number	Revision	Description	Issue Date
23T04Z80808-01	Rev.0	1st edition	2024-04-12
23T04Z80808-01	Rev.1	Add the external antenna information in P7. Recalculated the results of “Unwanted Emission” and “Band Edge Compliance” used external antenna gain. Add the note “The gain of external antenna is larger than the gain of internal antenna, and it should be considered that the EUT with external antenna is the worst case. All the tests are used external antenna.” in P11.	2024-04-23

Note: the latest revision of the test report supersedes all previous version.

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1. Test Laboratory

1.1. Introduction & Accreditation

Telecommunication Technology Labs, CAICT is an ISO/IEC 17025:2017 accredited test laboratory under American Association for Laboratory Accreditation (A2LA) with lab code 7049.01, and is also an FCC accredited test laboratory (CN1349), and ISED accredited test laboratory (CAB identifier:CN0066). The detail accreditation scope can be found on A2LA website.

1.2. Testing Location

Location 1: CTTL(huayuan North Road)

Address: No. 52, Huayuan North Road, Haidian District, Beijing,
P. R. China 100191

Location 2: CTTL(Kangding)

Address: No. 18A, Kangding Street, Beijing
Economic-Technology
Development Area, Beijing, P. R. China 100191

1.3. Testing Environment

Extreme Temperature: -30/+50°C

Relative Humidity: 20-75%

1.4. Project Data

Testing Start Date: 2024-02-29

Testing End Date: 2024-03-29

1.5. Signature



Zhang Ying
(Prepared this test report)



An Hui
(Reviewed this test report)



Zhang Xia
(Approved this test report)



2. Client Information

2.1. Applicant Information

Company Name: Baicells Technologies Co., Ltd.
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2.2. Manufacturer Information

Company Name: Baicells Technologies Co., Ltd.
Address /Post: 9-10F,1stBldg.,No.81BeiqingRoad,Haidian District,Beijing,China
Contact: Back Huang
Email: contact@Baicells.com
Telephone: 400-108-0167
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3. Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1. About EUT

Description	5G Outdoor CPE
Model Name	SRT853L
FCC ID	2AG32SRT853L
Hardware revision	SRT853L_PCB_V1.00
Software revision	SRT853L_8.0.6_EQ100
mmW Frequency band	n261
IBW	50MHz/100MHz
Max Output power (EIRP)	57.62dBm
Antenna beam steering	Beam26&Beam282 Beam30&Beam286(Reference Beam Tables are showed in Annex E)
Internal antenna gain	16dBi
External antenna gain	30.4dBi
Channel bandwidth(s)/ Sub Carrier Spacing	50MHz or100 MHz/ 120 kHz
Modulations	CP-OFDM(QPSK, 16QAM, 64QAM, 256QAM) DFT-s-OFDM(PI/2 BPSK, QPSK, 16QAM, 64QAM, 256QAM)
Extreme vol. Limits	56VDC (POE)
Extreme temp. Tolerance	-40°C to +50°C

Note: Components list, please refer to documents of the manufacturer; it is also included in the original test record of CTTL.

Test frequencies used for radiated measurements:

Frequency (MHz)	bandwidth	CCs	comment
27525.00	50MHz	1	Low channel
27924.96	50MHz	1	middle channel
28324.92	50MHz	1	high channel
27550.08	100MHz	1	Low channel
27924.96	100MHz	1	middle channel
28299.96	100MHz	1	high channel
27550.08 + 27650.04	100MHz	2	Low channel
27874.92 + 27974.88	100MHz	2	middle channel
28200.00 + 28299.96	100MHz	2	high channel

3.2. Internal Identification of EUT used during the test

EUT ID*	IMEI / Serial Number	HW Version	SW Version
UT01a	T853L6AAxD092800027	SRT853L_PCB_V1.00	SRT853L_8.0.6_EQ100

*EUT ID: is used to identify the test sample in the lab internally.

The IMEI and SW version information were provided by the applicant.

3.3. Internal Identification of AE used during the test

AE ID*	Description	Model	Manufacturer
AE1	POE Adapter	P060U04	I.T.E. POWER SUPPLY

4. Reference Documents

4.1. Documents supplied by applicant

EUT parameters, referring to chapter 3.1 for detailed information, is supplied by the client or manufacturer, which is the basis of testing.

4.2. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
FCC Part 30	UPPER MICROWAVE FLEXIBLE USE SERVICE	10-1-23 Edition
ANSI C63.26	American National Standard for Compliance Testing of Transmitters Used in Licensed Radio Services	2015
KDB 842590	Upper Microwave Flexible Use Service v01r02	April 20, 2021

5. Laboratory Environment

Semi/Full-anechoic chamber did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. = 15 %, Max. = 75 %
Shielding effectiveness	0.014MHz - 1MHz, >60dB; 1MHz - 1000MHz, >90dB.
Electrical insulation	> 2 M
Ground system resistance	< 4
Normalised site attenuation (NSA)	< \pm 4 dB, 3m/10m distance, from 30 to 1000 MHz
Site voltage standing-wave ratio (SVSWR)	Between 0 and 6 dB, from 1GHz to 18GHz

6. Summary Of Test Result

n261

Items	Test Name	Clause in FCC rules	limit	Verdict
1	Output Power	2.1046 30.202(a)	75dBm/100 MHz	P
2	Unwanted Emission	30.203	-13dBm/MHz	P
3	Frequency Stability	2.1055	Fundamental emissions stay within authorized frequency block	P
4	Occupied Bandwidth	2.1049	Not Applicable	Reporting only
5	Band Edge Compliance	2.1051 30.203	-5dBm/MHz from the band edge up to 10% of the channel BW	P

Note: The gain of external antenna is larger than the gain of internal antenna, and it should be considered that the EUT with external antenna is the worst case. All the tests are used external antenna.

Terms used in Verdict column

P	Pass. The EUT complies with the essential requirements in the standard.
NP	Not Performed. The test was not performed by CTTL.
NA	Not Applicable. The test was not applicable.
BR	Re-use test data from basic model report.
F	Fail. The EUT does not comply with the essential requirements in the standard.
Reporting only	No limit. Just report the measurement.

Explanation of worst-case configuration

The worst-case scenario for all measurements is based on the output power, occupied bandwidth, band edge emission measurement investigation results. The test results shown in the following sections represent the worst case measurement results. For each frequency only the maximum measurement results of Beam ID were represent in the report. The Beam ID of maximum results for low, center and high frequency of different chains maybe vary.

7. Measurement Uncertainty

Measurement Uncertainty:

Location 2: CTTL(Kangding)

Frequency Range	Uncertainty(dB) (k=2)
30MHz-1GHz	5.64
1GHz-18GHz	4.23
Above 18GHz	3.72

Note: Uncertainty of the above 18GHz, giving only the worst case.

Location 1: CTTL(huayuan North Road)

Frequency Range	Uncertainty(dB) (k=2)
18GHz-40GHz	3.4

8. Test Equipment Utilized

NO.	NAME	TYPE	SERIES NUMBER	PRODUCER	CAL. DUE DATE	CAL. INTERVAL
1	Spectrum Analyzer	FSW67	103290	R&S	2024-11-28	1 year
3	Antenna	VULB 9163	482	SCHWARZBECK	2025-01-03	2 years
4	Antenna	3115	00146404	ETS-Lindgren	2024-05-05	1 year
5	Antenna	3116	2661	ETS-Lindgren	2025-01-30	2 years
6	Upconverter (50GHz-75GHz)	SMZ75	101309	R&S	2025-01-14	4 years
7	Upconverter (75GHz-110GHz)	SMZ110	101357	R&S	2025-01-14	4 years
8	(downconverter)Harmonic Mixer(60GHz-90GHz)	FS-Z90	101655	R&S	2025-01-14	4 years
9	(downconverter)Harmonic Mixer(75GHz-110GHz)	FS-Z110	101463	R&S	2025-01-14	4 years
10	Standard Gain Horn Antenna (40GHz-60GHz)	LB-19-25	J202024086	A-INFO	/	/
11	Standard Gain Horn Antenna (40GHz-60GHz)	LB-19-25	J202024087	A-INFO	/	/
12	Standard Gain Horn Antenna (60GHz-90GHz)	LB-12-25	J202062912	A-INFO	/	/
13	Standard Gain HornAntenna (50GHz-75GHz)	LB-15-25	J202062019	A-INFO	/	/
14	Standard Gain Horn Antenna (75GHz-110GHz)	LB-10-25	J202023231	A-INFO	/	/
15	Standard Gain Horn Antenna (75GHz-110GHz)	LB-10-25	J202023232	A-INFO	/	/

Test Item	Test Software and Version	Software Vendor
Output Power	mmWave InBand testing V1.2.2	CAICT
Unwanted Emission	mmW Spurious Emission V5.0	CAICT
Occupied Bandwidth	mmWave InBand testing V1.2.2	CAICT
Band Edge Compliance	mmWave InBand testing V1.2.2	CAICT

Annex A: Radiated Test Setup

The radiated test facilities consisted of an indoor 3m/10m semi-anechoic chamber used for final measurements and exploratory measurements from 30MHz-18GHz, when necessary for radiated emissions measurements in the spurious domain. According to Clause 5 in ANSI C63.4-2014, absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections for measurements above 1GHz (Figure A.2). For measurements below 1GHz, the absorbers are removed (Figure A.1).

Radiated measurement test sites shall conform to the site validation criteria called out in CISPR 16-1-4:2019 above 18 GHz. The test object is mounted on a positioner (Figure A.3). The positioner is used to move the test object according to the sampling grid. A measurement antenna is placed in the chamber at a suitable measurement antenna far-field distance.

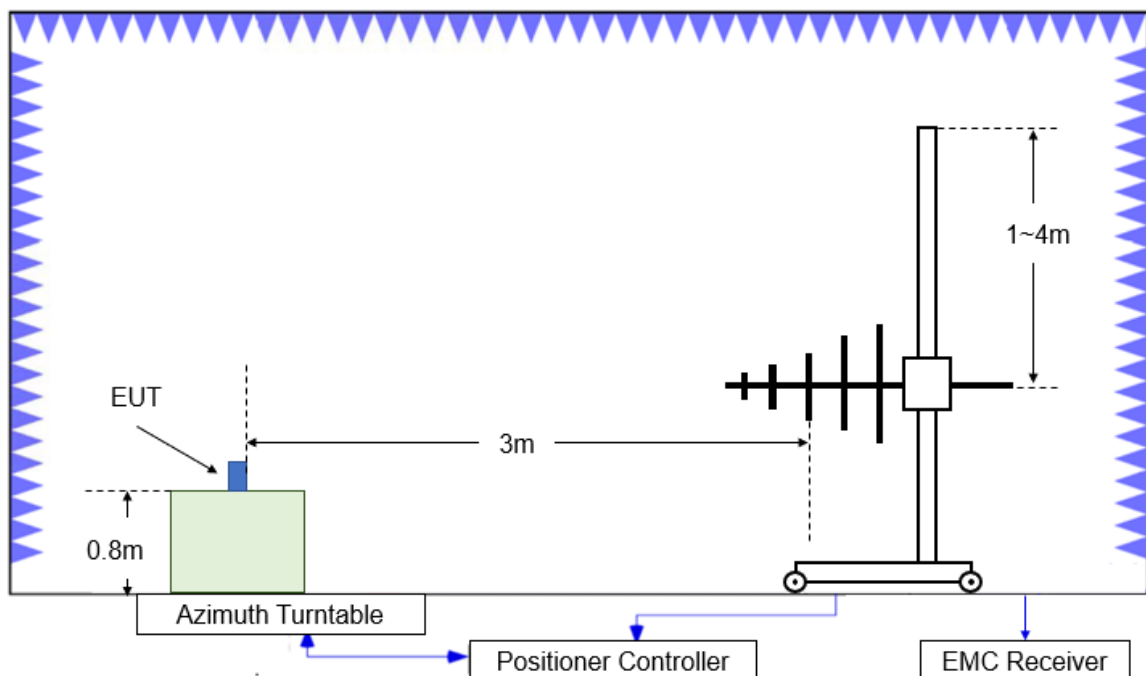


Figure A.1. Test Site Diagram (30MHz-1GHz)

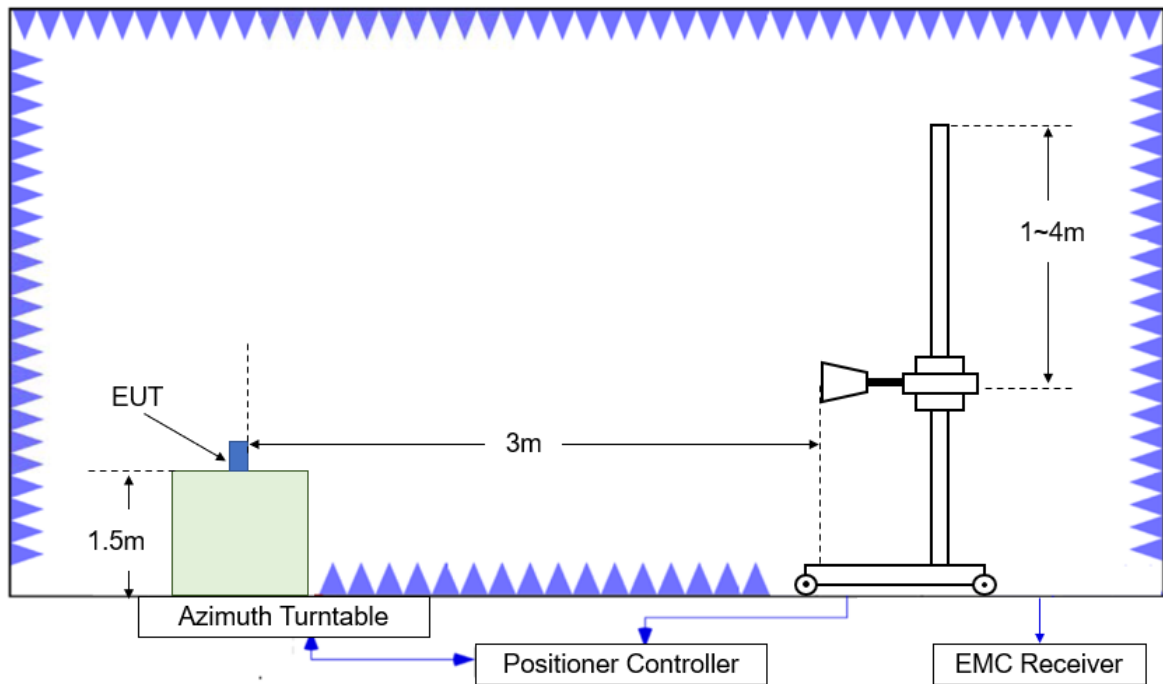


Figure A.2. Test Site Diagram (1GHz-18GHz)

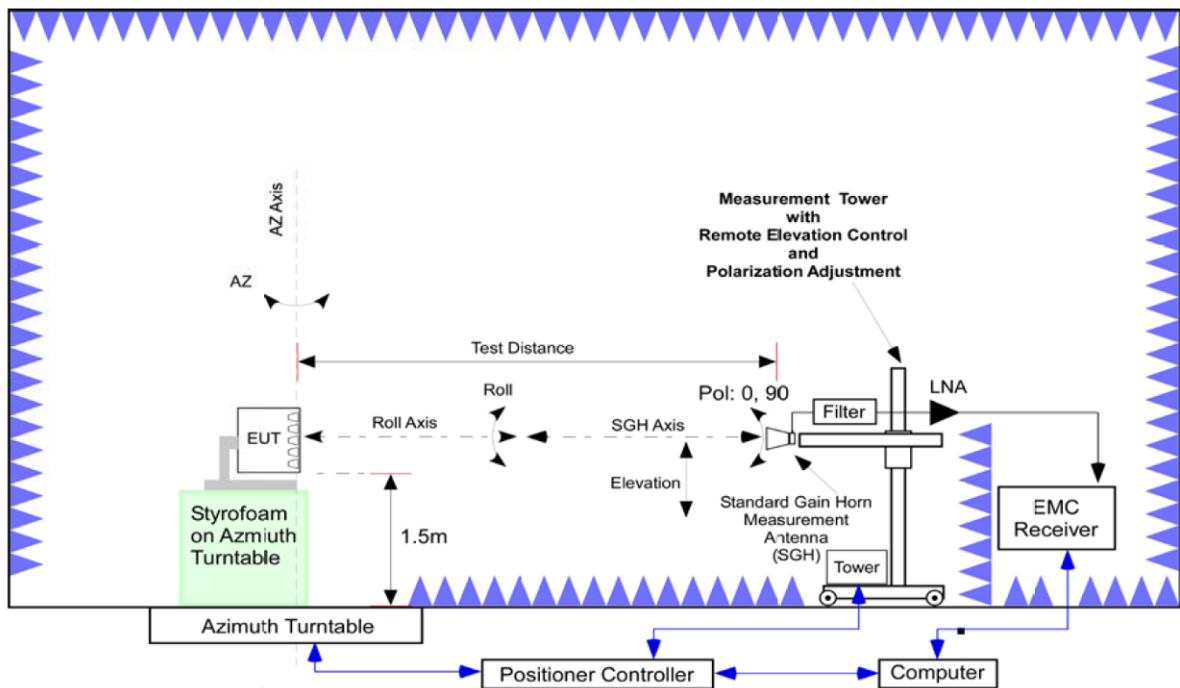


Figure A.3. Test Site Diagram (above 18GHz)

Annex B: Measurement Results

B.1 Radiated Output Power

B.1.1 Summary

In all cases, output power is within the specified limits.

30.202 (a) For fixed and base stations operating in connection with mobile systems, the average power of the sum of all antenna elements is limited to an equivalent isotopically radiated power (EIRP) density of +75dBm/100 MHz. For channel bandwidths less than 100 MHz the EIRP must be reduced proportionally and linearly based on the bandwidth relative to 100 MHz.

B.1.2 Minimum Measurement Distance Evaluation

According to KDB842590 D01, the measurements of the fundamental emission, out of band, harmonics and spurious emissions shall be made in the far field of the measurement antenna. The

far-field boundary for mmW antennas is greater than or equal to $2D^2/\lambda$ (with D being the largest dimension of the antenna, and λ the wavelength of the emission). We calculate the far-field boundary and the test distance meet the requirement of standard.

For fundamental or out-of-band emissions the largest far-field distance of either the EUT antenna or measurement antenna shall be used. For spurious emissions the far-field distance will be based on the measurement antenna.

	Antenna	D(mm)	λ (mm)	far-field boundary (m)	Measurement distance(m)
18-40GHz	EUT mmW Antenna	33.65	16.8	0.37	3

B.1.3 Method of Measurements

ANSI C63.26 chapter 5.5.2.1: Such radiated measurements shall use substitution methods unless a test site validated to ANSI C63.4 requirements is utilized, in which case, radiated fundamental and/or unwanted emissions can be measured using the direct radiated field strength method.

The EUT was set up for the max output power with pseudo random data modulation.

These measurements were done at 3 frequencies (bottom, middle and top of operational frequency range) for each bandwidth.

An spectrum analyzer is used to perform RF output power measurements, the fundamental condition that measurements be performed only over durations of active transmissions at maximum output power level applies. Thus, a spectrum analyzer can always be used to perform the measurement when the EUT can be configured to transmit continuously.

The EIRP measurement used integration method and the bandwidth is 100MHz.

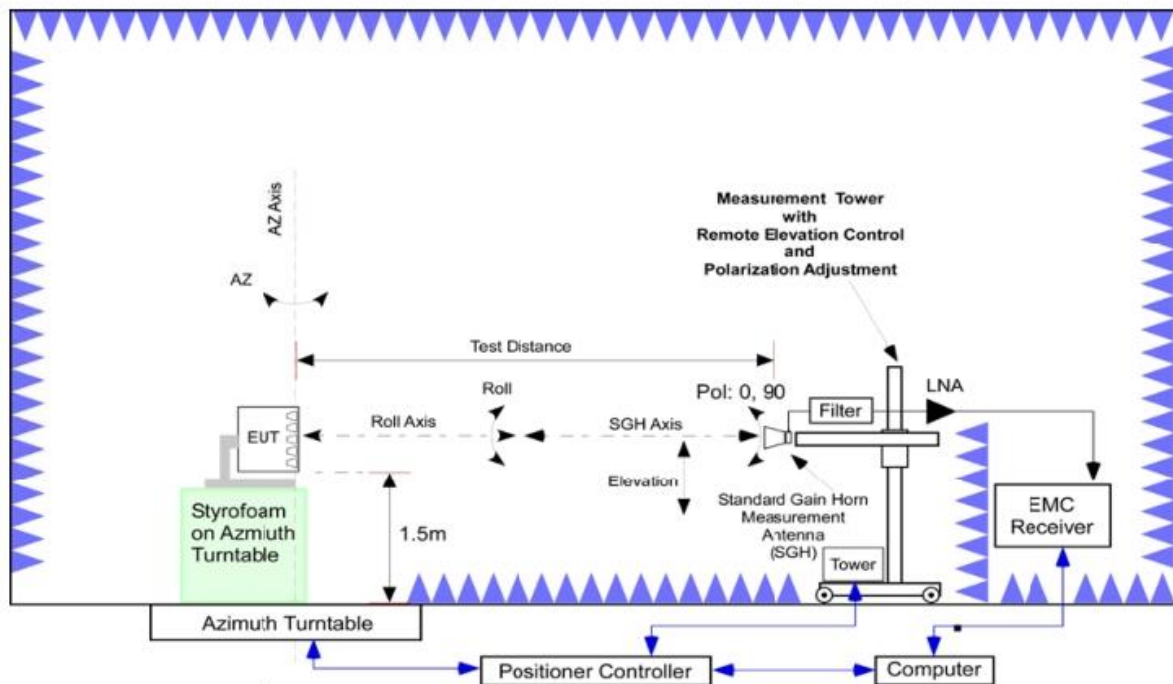
B.1.4 Test Procedure

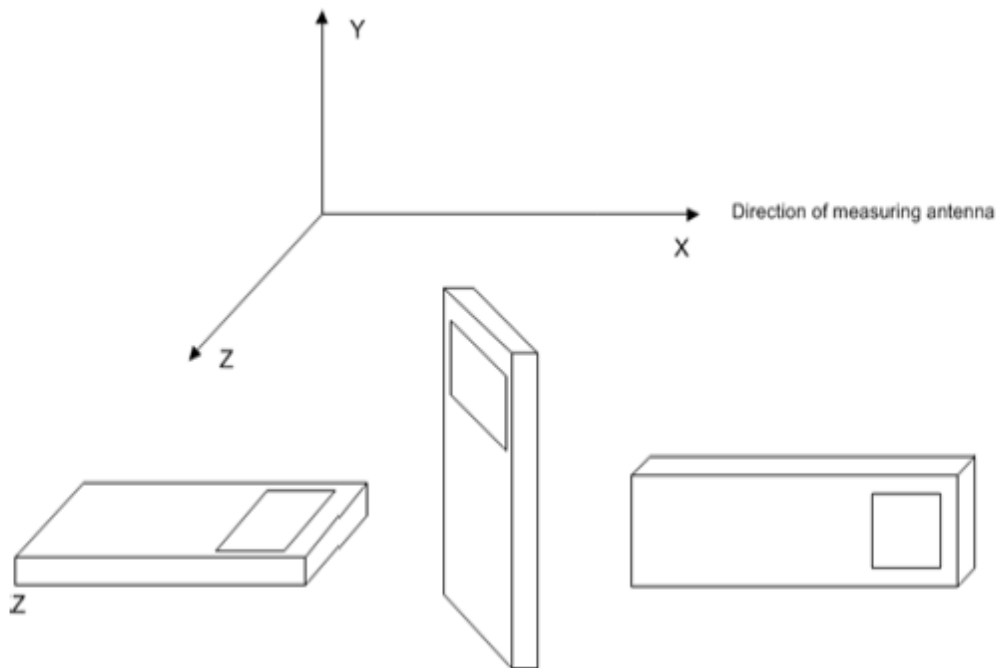
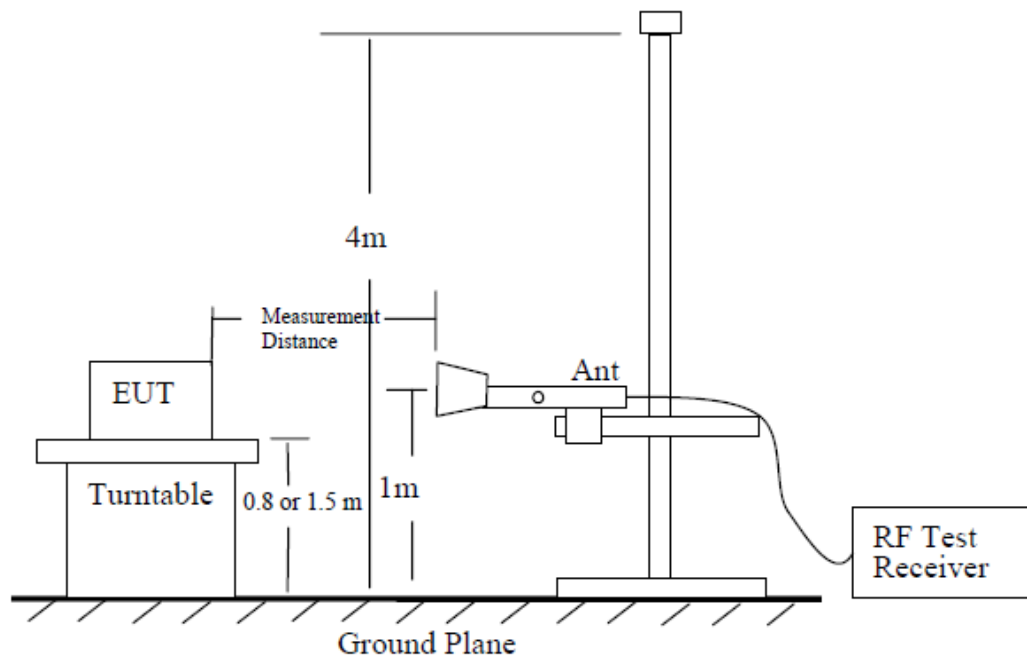
According to Clause 5.2.4.4 in ANSI C63.26-2015 and Clause 4.2 in KDB 842590 D01 v01r02

1. Set EUT at maximum output power
2. Select channels for each band and proper modulation

3. Enable channel power measurement function of spectrum analyzer
4. Set RBW = 1% to 5% of the OBW, not to exceed 1MHz
5. Set VBW $\geq 3 \times$ RBW
6. Set span to $2 \times$ to $3 \times$ the OBW
7. Set number of measurement points in sweep $\geq 2 \times$ span/RBW
8. Set Detector = RMS (power averaging)
9. Set Sweep time = auto-couple
10. Trace average at least 100 traces in power averaging (rms) mode
11. Compute the power by integrating the spectrum across the OBW of the signal for signals with continuous operation

Using the test configuration as follow, measure the radiated emissions directly from the EUT and convert the measured field strength or received power to ERP or EIRP, as required, for comparison to the applicable limits.





The emission characteristics of the EUT can be identified from the pre-scan measurement information.

Exploratory radiated measurements (pre-scans) may be performed to determine the general EUT radiated emissions characteristics and, when necessary, the EUT-to-measurement antenna orientation that produces the maximum emission amplitude. Pre-scans shall only be used to determine the emission frequencies (i.e., not amplitude levels). The information garnered from a pre-scan can then be used to perform final compliance measurements using either the substitution or direct field strength method.

For radiated emissions measurements performed at frequencies less than or equal to 1 GHz,

the EUT shall be placed on a RF-transparent table or support at a nominal height of 80 cm above the reference ground plane. Radiated measurements shall be made with the measurement antenna positioned in both horizontal and vertical polarization. The measurement antenna shall be varied from 1 m to 4 m in height above the reference ground in a search for the relative positioning that produces the maximum radiated signal level (i.e., field strength or received power). When orienting the measurement antenna in vertical polarization, the minimum height of the lowest element of the antenna shall clear the site reference ground plane by at least 25 cm.

For radiated measurements performed at frequencies above 1 GHz, the EUT shall be placed on an RF transparent table or support at a nominal height of 1.5 m above the ground plane. When maximizing the emissions from the EUT for measurement, the EUT and its transmitting antenna(s) shall be rotated through 360°. For each mode of operation to be tested, the frequency spectrum (based on findings from exploratory measurements) shall be monitored.

Test Note:

EIRP was calculated from measuring field strength by the following formula:

$$\text{EIRP (dBm)} = E \text{ (dB } \mu \text{ V/m)} + 20\log(D) - 104.8$$

where

$$E \text{ (dB } \mu \text{ V/m)} = \text{Measured amplitude level (dBm)} + 107 + \text{Cable Loss (dB)} + \text{Antenna Factor (dB/m)}$$

where

$$\text{Antenna Factor (dB/m)} = 20\log(F) - \text{Antenna Gain(dBi)} - 29.76$$

Then the average EIRP reported below is calculated by:

$$\text{EIRP (dBm)} = \text{Measured amplitude level (dBm)} - \text{Antenna Gain(dBi)} + \text{Cable Loss(dB)} + 20\log(F) + 20\log(D) - 27.56$$

Where:

F: frequency (MHz)

D: Distance(m) = 3m

According to ANSI C63.26 4.2.3, Additional amplitude separation between the maximum input signal level and the spectrum analyzer reference level may be required if the signal under measurement is pulsed and its output power or PSD are to be averaged over the duty cycle. In this case, an additional amplitude margin relative to the reference level, determined from $10 \log(1/\text{duty cycle})$, may be required. For example, the reference level should be set 3 dB higher if the settings are based on power or PSD measurements that are averaged over a 50% duty cycle. This correction must be made in addition to the PAPR correction described above. When performing fundamental emission power measurements, the reference level setting shall be based on the maximum fundamental power at the input to the spectrum analyzer. As a measurement precaution, any signals input to the measurement instrumentation should be suspected of having the potential for overload until proven otherwise.

The measurement is operated on 20% duty cycle, the reference level should be set 7 dB higher.

B.1.5 Measurement Result

Note: We choose the worst modulation by the EIRP of middle channel, the high channel and low channel measure the EIRP only with the worst modulation.

The plots are showed in Annex D.1.

Note: The measured EIRP levels are below the TRP limit and the early exit condition is met.

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Mid	50	1	CP-OFDM QPSK	320	48.31	55.31	75.00	19.69	H
					47.29	54.29	75.00	20.71	V
Mid	50	1	CP-OFDM 16QAM	320	47.66	54.66	75.00	20.34	H
					47.15	54.15	75.00	20.85	V
Mid	50	1	CP-OFDM 64QAM	320	44.91	51.91	75.00	23.09	H
					44.08	51.08	75.00	23.92	V
Mid	50	1	CP-OFDM 256QAM	320	41.79	48.79	75.00	26.21	H
					41.34	48.34	75.00	26.66	V

The high channel and low channel measure the EIRP only with the worst modulation

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	50	1	CP-OFDM QPSK	320	48.01	55.01	75.00	19.99	H
					47.88	54.88	75.00	20.12	V
High	50	1	CP-OFDM QPSK	320	47.15	54.15	75.00	20.85	H
					46.80	53.80	75.00	21.20	V

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Mid	50	1	CP-OFDM QPSK	1/15	40.16	47.16	75.00	27.84	H
					39.84	46.84	75.00	28.16	V
Mid	50	1	CP-OFDM 16QAM	1/15	39.71	46.71	75.00	28.29	H
					39.74	46.74	75.00	28.26	V
Mid	50	1	CP-OFDM 64QAM	1/15	40.01	47.01	75.00	27.99	H
					39.54	46.54	75.00	28.46	V
Mid	50	1	CP-OFDM 256QAM	1/15	30.31	37.31	75.00	37.69	H
					30.28	37.28	75.00	37.72	V

The high channel and low channel measure the EIRP only with the worst modulation

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	50	1	CP-OFDM QPSK	1/15	37.73	44.73	75.00	30.27	H
					38.73	45.73	75.00	29.27	V
High	50	1	CP-OFDM QPSK	1/15	40.41	47.41	75.00	27.59	H
					40.91	47.91	75.00	27.09	V

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Mid	50	1	DFT-s-OFDM PI/2 BPSK	32/0	48.64	55.64	75.00	19.36	H
					48.41	55.41	75.00	19.59	V
Mid	50	1	DFT-s-OFDM QPSK	32/0	48.83	55.83	75.00	19.17	H
					47.96	54.96	75.00	20.04	V
Mid	50	1	DFT-s-OFDM 16QAM	32/0	48.65	55.65	75.00	19.35	H
					47.30	54.30	75.00	20.70	V
Mid	50	1	DFT-s-OFDM 64QAM	32/0	47.61	54.61	75.00	20.39	H
					46.64	53.64	75.00	21.36	V
Mid	50	1	DFT-s-OFDM 256QAM	32/0	40.64	47.64	75.00	27.36	H
					39.81	46.81	75.00	28.19	V

The high channel and low channel measure the EIRP only with the worst modulation

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	50	1	CP-OFDM QPSK	32/0	48.40	55.40	75.00	19.60	H
					48.04	55.04	75.00	19.96	V
High	50	1	CP-OFDM QPSK	32/0	46.75	53.75	75.00	21.25	H
					47.14	54.14	75.00	20.86	V

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Mid	50	1	DFT-s-OFDM PI/2 BPSK	1/15	37.95	44.95	75.00	30.05	H
					42.03	49.03	75.00	25.97	V
Mid	50	1	DFT-s-OFDM QPSK	1/15	37.62	44.62	75.00	30.38	H
					40.47	47.47	75.00	27.53	V
Mid	50	1	DFT-s-OFDM 16QAM	1/15	37.29	44.29	75.00	30.71	H
					40.45	47.45	75.00	27.55	V
Mid	50	1	DFT-s-OFDM 64QAM	1/15	37.80	44.80	75.00	30.20	H
					40.51	47.51	75.00	27.49	V
Mid	50	1	DFT-s-OFDM 256QAM	1/15	31.89	38.89	75.00	36.11	H
					34.85	41.85	75.00	33.15	V

The high channel and low channel measure the EIRP only with the worst modulation

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	50	1	DFT-s-OFDM M BPSK	1/15	40.15	47.15	75.00	27.85	H
					39.00	46.00	75.00	29.00	V
High	50	1	DFT-s-OFDM M BPSK	1/15	35.06	42.06	75.00	32.94	H
					41.45	48.45	75.00	26.55	V

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Mid	100	1	CP-OFDM QPSK	660	49.05	56.05	75.00	18.95	H
					48.10	55.10	75.00	19.90	V
Mid	100	1	CP-OFDM 16QAM	660	47.31	54.31	75.00	20.69	H
					47.12	54.12	75.00	20.88	V
Mid	100	1	CP-OFDM 64QAM	660	45.09	52.09	75.00	22.91	H
					44.33	51.33	75.00	23.67	V
Mid	100	1	CP-OFDM 256QAM	660	42.15	49.15	75.00	25.85	H
					41.20	48.20	75.00	26.80	V

The high channel and low channel measure the EIRP only with the worst modulation

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	100	1	CP-OFDM QPSK	660	48.22	55.22	75.00	19.78	H
					48.18	55.18	75.00	19.82	V
High	100	1	CP-OFDM QPSK	660	47.09	54.09	75.00	20.91	H
					47.29	54.29	75.00	20.71	V

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Mid	100	1	CP-OFDM QPSK	1/32	40.30	47.30	75.00	27.70	H
					40.12	47.12	75.00	27.88	V
Mid	100	1	CP-OFDM 16QAM	1/32	40.86	47.86	75.00	27.14	H
					40.23	47.23	75.00	27.77	V
Mid	100	1	CP-OFDM 64QAM	1/32	41.44	48.44	75.00	26.56	H
					39.93	46.93	75.00	28.07	V
Mid	100	1	CP-OFDM 256QAM	1/32	31.07	38.07	75.00	36.93	H
					30.15	37.15	75.00	37.85	V

The high channel and low channel measure the EIRP only with the worst modulation

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	100	1	CP-OFDM 64QAM	1/32	39.78	46.78	75.00	28.22	H
					39.85	46.85	75.00	28.15	V
High	100	1	CP-OFDM 64QAM	1/32	41.69	48.69	75.00	26.31	H
					41.28	48.28	75.00	26.72	V

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Mid	100	1	DFT-s-OFDM PI/2 BPSK	64/0	49.93	56.93	75.00	18.07	H
					49.76	56.76	75.00	18.24	V
Mid	100	1	DFT-s-OFDM QPSK	64/0	50.56	57.56	75.00	17.44	H
					49.94	56.94	75.00	18.06	V
Mid	100	1	DFT-s-OFDM 16QAM	64/0	49.13	56.13	75.00	18.87	H
					48.61	55.61	75.00	19.39	V
Mid	100	1	DFT-s-OFDM 64QAM	64/0	47.18	54.18	75.00	20.82	H
					46.78	53.78	75.00	21.22	V
Mid	100	1	DFT-s-OFDM 256QAM	64/0	41.74	48.74	75.00	26.26	H
					41.15	48.15	75.00	26.85	V

The high channel and low channel measure the EIRP only with the worst modulation

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	100	1	DFT-s-OFDM M QPSK	64/0	50.62	57.62	75.00	17.38	H
					50.49	57.49	75.00	17.51	V
High	100	1	DFT-s-OFDM M QPSK	64/0	46.62	53.62	75.00	21.38	H
					46.64	53.64	75.00	21.36	V

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Mid	100	1	DFT-s-OFDM PI/2 BPSK	1/31	40.48	47.48	75.00	27.52	H
					39.78	46.78	75.00	28.22	V
Mid	100	1	DFT-s-OFDM QPSK	1/31	44.34	51.34	75.00	23.66	H
					31.53	38.53	75.00	36.47	V
Mid	100	1	DFT-s-OFDM 16QAM	1/31	42.89	49.89	75.00	25.11	H
					30.63	37.63	75.00	37.37	V
Mid	100	1	DFT-s-OFDM 64QAM	1/31	43.58	50.58	75.00	24.42	H
					31.81	38.81	75.00	36.19	V
Mid	100	1	DFT-s-OFDM 256QAM	1/31	36.14	43.14	75.00	31.86	H
					25.56	32.56	75.00	42.44	V

The high channel and low channel measure the EIRP only with the worst modulation

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	100	1	DFT-s-OFDM M QPSK	1/31	43.41	50.41	75.00	24.59	H
					35.54	42.54	75.00	32.46	V
High	100	1	DFT-s-OFDM M QPSK	1/31	44.65	51.65	75.00	23.35	H
					33.29	40.29	75.00	34.71	V

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Mid	100	2	CP-OFDM QPSK	660	43.25	50.25	75.00	24.75	H
					41.59	48.59	75.00	26.41	V
Mid	100	2	CP-OFDM 16QAM	660	42.35	49.35	75.00	25.65	H
					40.70	47.70	75.00	27.30	V
Mid	100	2	CP-OFDM 64QAM	660	40.40	47.40	75.00	27.60	H
					38.83	45.83	75.00	29.17	V
Mid	100	2	CP-OFDM 256QAM	660	38.61	45.61	75.00	29.39	H
					36.64	43.64	75.00	31.36	V

The high channel and low channel measure the EIRP only with the worst modulation

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	100	2	CP-OFDM QPSK	660	42.11	49.11	75.00	25.89	H
					40.33	47.33	75.00	27.67	V
High	100	2	CP-OFDM QPSK	660	43.69	50.69	75.00	24.31	H
					42.75	49.75	75.00	25.25	V

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Mid	100	2	CP-OFDM QPSK	1/32	36.12	43.12	75.00	31.88	H
					38.16	45.16	75.00	29.84	V
Mid	100	2	CP-OFDM 16QAM	1/32	34.74	41.74	75.00	33.26	H
					37.30	44.30	75.00	30.70	V
Mid	100	2	CP-OFDM 64QAM	1/32	34.93	41.93	75.00	33.07	H
					38.22	45.22	75.00	29.78	V
Mid	100	2	CP-OFDM 256QAM	1/32	26.47	33.47	75.00	41.53	H
					27.08	34.08	75.00	40.92	V

The high channel and low channel measure the EIRP only with the worst modulation

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	100	2	CP-OFDM QPSK	1/32	38.15	45.15	75.00	29.85	H
					33.52	40.52	75.00	34.48	V
High	100	2	CP-OFDM QPSK	1/32	38.49	45.49	75.00	29.51	H
					38.27	45.27	75.00	29.73	V

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Mid	100	2	DFT-s-OFDM PI/2 BPSK	64/0	42.56	49.56	75.00	25.44	H
					44.01	51.01	75.00	23.99	V
Mid	100	2	DFT-s-OFDM QPSK	64/0	42.69	49.69	75.00	25.31	H
					43.17	50.17	75.00	24.83	V
Mid	100	2	DFT-s-OFDM 16QAM	64/0	41.52	48.52	75.00	26.48	H
					42.67	49.67	75.00	25.33	V
Mid	100	2	DFT-s-OFDM 64QAM	64/0	39.65	46.65	75.00	28.35	H
					40.08	47.08	75.00	27.92	V
Mid	100	2	DFT-s-OFDM 256QAM	64/0	32.25	39.25	75.00	35.75	H
					32.87	39.87	75.00	35.13	V

The high channel and low channel measure the EIRP only with the worst modulation

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	100	2	DFT-s-OFDM M BPSK	64/0	34.03	41.03	75.00	33.97	H
					34.34	41.34	75.00	33.66	V
High	100	2	DFT-s-OFDM M BPSK	64/0	32.87	39.87	75.00	35.13	H
					45.47	52.47	75.00	22.53	V

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Mid	100	2	DFT-s-OFDM PI/2 BPSK	1/31	40.30	47.30	75.00	27.70	H
					28.18	35.18	75.00	39.82	V
Mid	100	2	DFT-s-OFDM QPSK	1/31	39.98	46.98	75.00	28.02	H
					34.77	41.77	75.00	33.23	V
Mid	100	2	DFT-s-OFDM 16QAM	1/31	40.36	47.36	75.00	27.64	H
					29.42	36.42	75.00	38.58	V
Mid	100	2	DFT-s-OFDM 64QAM	1/31	39.36	46.36	75.00	28.64	H
					34.12	41.12	75.00	33.88	V
Mid	100	2	DFT-s-OFDM 256QAM	1/31	33.84	40.84	75.00	34.16	H
					22.56	29.56	75.00	45.44	V

The high channel and low channel measure the EIRP only with the worst modulation

Module0, Beam ID: 26,282

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	100	2	DFT-s-OFDM M 16QAM	1/31	39.20	46.20	75.00	28.80	H
					29.47	36.47	75.00	38.53	V
High	100	2	DFT-s-OFDM M 16QAM	1/31	37.04	44.04	75.00	30.96	H
					38.66	45.66	75.00	29.34	V

The module1 (beam ID: 30, 286) measure the EIRP only with the worst modulation.

Module1, Beam ID: 30, 286

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	50	1	DFT-s-OFDM QPSK	32/0	43.35	50.35	75.00	24.65	H
					43.29	50.29	75.00	24.71	V
Mid	50	1	DFT-s-OFDM QPSK	32/0	44.26	51.26	75.00	23.74	H
					43.68	50.68	75.00	24.32	V
High	50	1	DFT-s-OFDM QPSK	32/0	42.65	49.65	75.00	25.35	H
					42.25	49.25	75.00	25.75	V

Module1, Beam ID: 30, 286

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	50	1	DFT-s-OFDM PI/2 BPSK	1/15	38.52	45.52	75.00	29.48	H
					40.33	47.33	75.00	27.67	V
Mid	50	1	DFT-s-OFDM PI/2 BPSK	1/15	38.54	45.54	75.00	29.46	H
					40.52	47.52	75.00	27.48	V
High	50	1	DFT-s-OFDM PI/2 BPSK	1/15	38.20	45.20	75.00	29.80	H
					38.54	45.54	75.00	29.46	V

Module1, Beam ID: 30, 286

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	100	1	DFT-s-OFDM QPSK	64/0	43.91	50.91	75.00	24.09	H
					42.64	49.64	75.00	25.36	V
Mid	100	1	DFT-s-OFDM QPSK	64/0	47.68	54.68	75.00	20.32	H
					46.82	53.82	75.00	21.18	V
High	100	1	DFT-s-OFDM QPSK	64/0	46.74	53.74	75.00	21.26	H
					45.06	52.06	75.00	22.94	V

Module1, Beam ID: 30, 286

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	100	1	DFT-s-OFDM QPSK	1/31	41.61	48.61	75.00	26.39	H
					27.96	34.96	75.00	40.04	V
Mid	100	1	DFT-s-OFDM QPSK	1/31	43.86	50.86	75.00	24.14	H
					31.17	38.17	75.00	36.83	V
High	100	1	DFT-s-OFDM QPSK	1/31	36.55	43.55	75.00	31.45	H
					32.68	39.68	75.00	35.32	V

Module1, Beam ID: 30, 286

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	100	2	DFT-s-OFDM PI/2 BPSK	64/0	35.09	42.09	75.00	32.91	H
					38.36	45.36	75.00	29.64	V
Mid	100	2	DFT-s-OFDM PI/2 BPSK	64/0	36.31	43.31	75.00	31.69	H
					38.77	45.77	75.00	29.23	V
High	100	2	DFT-s-OFDM PI/2 BPSK	64/0	36.97	43.97	75.00	31.03	H
					39.32	46.32	75.00	28.68	V

Module1, Beam ID: 30, 286

Channel	Bandwidth	CCs	Modulation	RB	measurement EIRP	Avg EIRP	Limit	Margin	Pol
	(MHz)			(Size/Offset)	(dBm)	(dBm)	(dBm)	(dB)	
Low	100	2	DFT-s-OFDM 16QAM	1/31	37.20	44.20	75.00	30.80	H
					35.68	42.68	75.00	32.32	V
Mid	100	2	DFT-s-OFDM 16QAM	1/31	40.18	47.18	75.00	27.82	H
					28.61	35.61	75.00	39.39	V
High	100	2	DFT-s-OFDM 16QAM	1/31	40.79	47.79	75.00	27.21	H
					29.21	36.21	75.00	38.79	V

B.2 Emission Limit

B.2.1 Summary

The spectrum of FR2 n261 was scanned from 30 MHz to 100GHz. All modes of operation were investigated and the worst case configuration results are reported in this section.

30.203 (a) The conductive power or the total radiated power of any emission outside a licensee's frequency block shall be -13dBm/MHz or lower. However, in the bands immediately outside and adjacent to the licensee's frequency block, having a bandwidth equal to 10 percent of the channel bandwidth, the conductive power or the total radiated power of any emission shall be -5 dBm/MHz or lower.

B.2.2 Minimum Measurement Distance Evaluation

According to KDB842590 D01, the measurements of the fundamental emission, out of band, harmonics and spurious emissions shall be made in the far field of the measurement antenna. The far-field boundary for mmW antennas is greater than or equal to $2D^2/\lambda$ (with D being the largest dimension of the antenna, and λ the wavelength of the emission). We calculate the far-field boundary and the test distance meet the requirement of standard.

	Antenna model	D(mm)	λ (mm)	far-field boundary (m)	Measurement distance(m)
40-60GHz	LB-19-25	0.063891	0.0050	1.63	3
60-75GHz	LB-15-25	0.041231	0.0033	1.02	3
75-100GHz	LB-10-25	0.035609	0.0030	0.85	3

B.2.3 Measurement Method

The measurement procedures in ANSI C63.26 are used.

The spectrum was scanned from 30 MHz to the 5th harmonic of the highest frequency generated within the equipment. The resolution bandwidth is set as outlined in Part 30.203.

The spectrum is scanned with the mobile station transmitting at carrier frequencies that pertain to low, mid and high channels of FR2 n261.

ANSI C63.26 chapter 5.5.2.1: Such radiated measurements shall use substitution methods unless a test site validated to ANSI C63.4 requirements is utilized, in which case, radiated fundamental and/or unwanted emissions can be measured using the direct radiated field strength method.

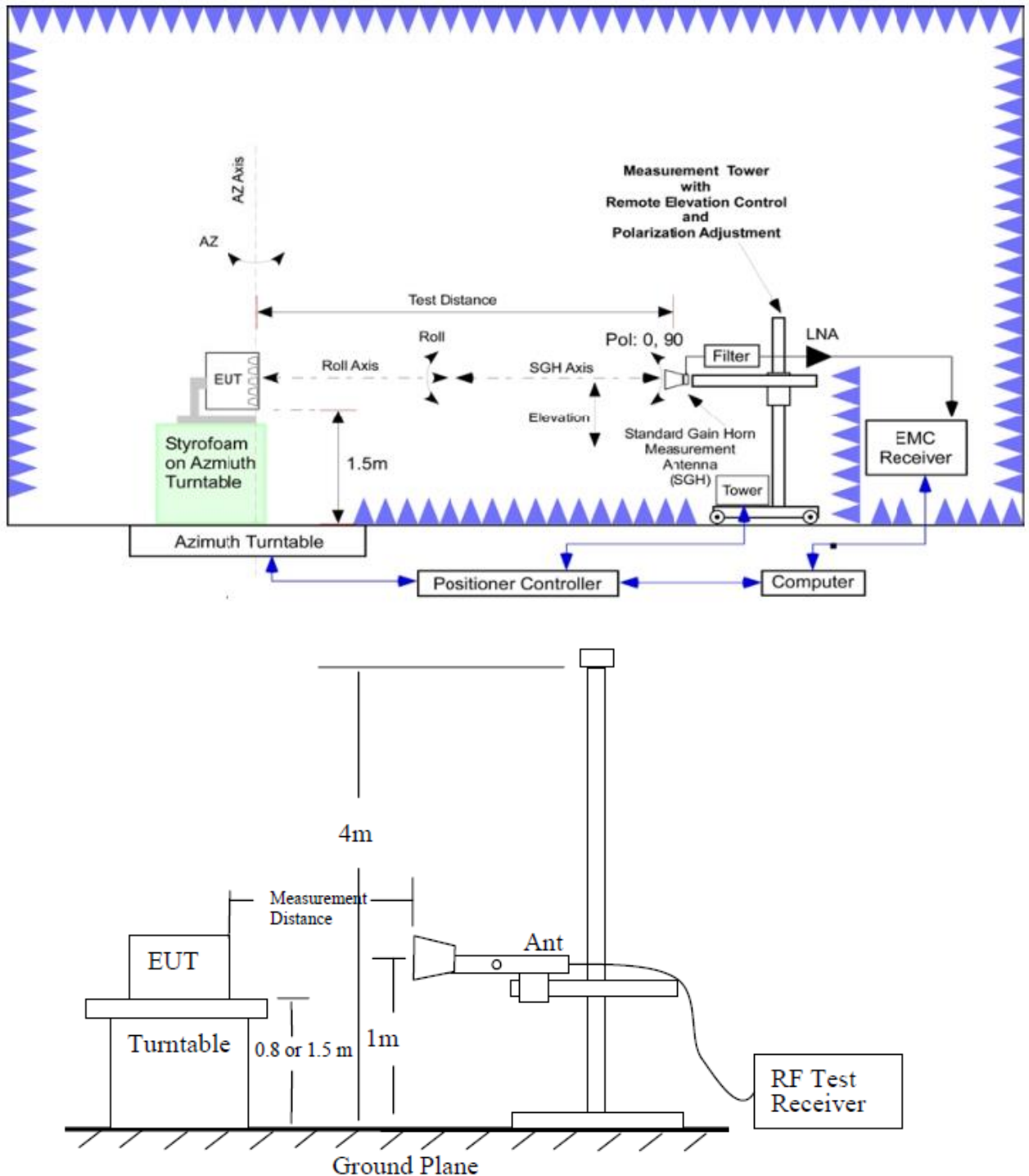
B.2.4 Test Procedure

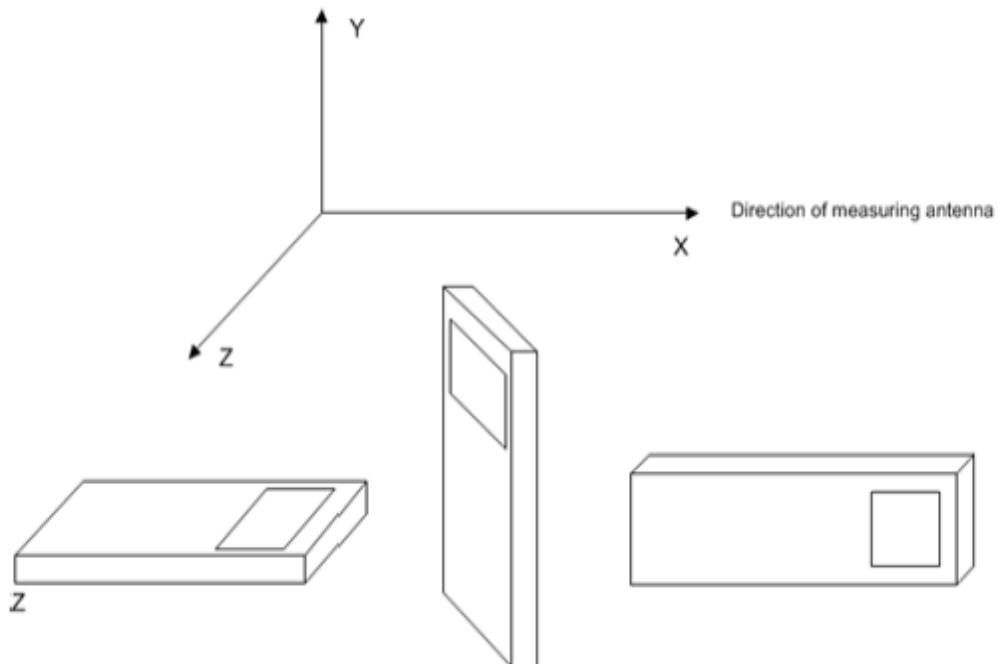
According to Clause 5.5 in ANSI C63.26-2015, 30.203 (b) and Clause 4.4 in KDB 842590 D01 v01r02

1. Set EUT at maximum output power
2. Select channels for each band and proper modulation
3. Set RBW=1MHz, VBW=3MHz
4. Set number of measurement points in sweep $\geq 2 \times \text{span}/\text{RBW}$
5. Set Detector = RMS
6. Set Sweep time = auto-couple

7. Trace average at least 100 traces in power averaging (rms) mode
8. The trace was allowed to stabilize

Using the test configuration as follow, measure the radiated emissions directly from the EUT and convert the measured field strength or received power to ERP or EIRP, as required, for comparison to the applicable limits.





The emission characteristics of the EUT can be identified from the pre-scan measurement information.

Exploratory radiated measurements (pre-scans) may be performed to determine the general EUT radiated emissions characteristics and, when necessary, the EUT-to-measurement antenna orientation that produces the maximum emission amplitude. Pre-scans shall only be used to determine the emission frequencies (i.e., not amplitude levels). The information garnered from a pre-scan can then be used to perform final compliance measurements using either the substitution or direct field strength method.

For radiated emissions measurements performed at frequencies less than or equal to 1 GHz, the EUT shall be placed on a RF-transparent table or support at a nominal height of 80 cm above the reference ground plane. Radiated measurements shall be made with the measurement antenna positioned in both horizontal and vertical polarization. The measurement antenna shall be varied from 1 m to 4 m in height above the reference ground in a search for the relative positioning that produces the maximum radiated signal level (i.e., field strength or received power). When orienting the measurement antenna in vertical polarization, the minimum height of the lowest element of the antenna shall clear the site reference ground plane by at least 25 cm.

The radiated emission measurements of all non-harmonic and harmonics of the transmit frequency through the 5th harmonic were measured with peak detector.

For radiated measurements performed at frequencies above 1 GHz, the EUT shall be placed on an RF transparent table or support at a nominal height of 1.5 m above the ground plane. When maximizing the emissions from the EUT for measurement, the EUT and its transmitting antenna(s) shall be rotated through 360°. For each mode of operation to be tested, the frequency spectrum (based on findings from exploratory measurements) shall be monitored.

Final measurements shall be performed for the worst case combination(s) of variable technical parameters that result in the maximum measured emission amplitude, record the frequency and

amplitude of the highest fundamental emission (if applicable), and the frequency and amplitude data for the six highest-amplitude spurious emissions.

Test Note:

1. The average EIRP reported below is calculated by:

30M-18GHz: $EIRP \text{ (dBm)} = \text{Spectrum Analyzer Level (dBm)} + \text{Path Loss(dB)}$

18GHz-60GHz: $EIRP \text{ (dBm)} = \text{Spectrum Analyzer Level (dBm)} - \text{Antenna Gain (dBi)} + \text{Cable Loss (dB)} + 20\log(F) + 20\log(D) - 27.56$

60GHz-110GHz: $EIRP \text{ (dBm)} = \text{Spectrum Analyzer Level (dBm)} - \text{Antenna Gain (dBi)} + \text{converter Loss (dB)} + 20\log(F) + 20\log(D) - 27.56$

Where: F: frequency (MHz), D: Distance(m), the distance for different frequency range as shown in table.

Frequency Range	Distance(m)	Frequency Range	Distance(m)
30MHz-1GHz	3	60GHz-75GHz	3
1GHz-18GHz	3	75GHz-100GHz	3
18GHz-40GHz	3		
40GHz-60GHz	3		

2. The TRP method refers to the Clause 4.4 of KDB 842590 D01 v01r02. If EIRP measurement results exceed the emission limit, then TRP measurement will be used as an alternative method.

B.2.5 Measurement Results Table (worse case of the power measured)

The plots are showed in Annex D.2.

Note: The measured EIRP levels are below the TRP limit and the early exit condition is met.

Module0, Beam ID: 26,282

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	26,470.77	50	1	PUSCH DFT QPSK	32/0	-12.92	30.4	-43.32	-13	30.32	H
low	27,468.17	50	1		32/0	-10.75	30.4	-41.15	-13	28.15	H
low	27,473.39	50	1		32/0	-8.24	30.4	-38.64	-13	25.64	H
low	27,478.61	50	1		32/0	-5.96	30.4	-36.36	-13	23.36	H
low	27,485.26	50	1		32/0	-6.38	30.4	-36.78	-13	23.78	H
low	27,489.05	50	1		32/0	-5.16	30.4	-35.56	-13	22.56	H

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	27,085.25	50	1	PUSCH DFT QPSK	32/0	-6.79	30.4	-37.19	-13	24.19	V
low	28,362.41	50	1		32/0	-1.18	30.4	-31.58	-13	18.58	V
low	28,368.20	50	1		32/0	-3.04	30.4	-33.44	-13	20.44	V
low	28,373.51	50	1		32/0	-3.67	30.4	-34.07	-13	21.07	V
low	28,379.29	50	1		32/0	-5.64	30.4	-36.04	-13	23.04	V
low	28,384.60	50	1		32/0	-7.64	30.4	-38.04	-13	25.04	V

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
Middle	25,907.07	50	1	PUSCH DFT QPSK	32/0	-22.28	30.4	-52.68	-13	39.68	H
Middle	26,945.75	50	1		32/0	-21.58	30.4	-51.98	-13	38.98	H
Middle	27,084.78	50	1		32/0	-9.76	30.4	-40.16	-13	27.16	H
Middle	27,317.76	50	1		32/0	-21.31	30.4	-51.71	-13	38.71	H
Middle	28,851.04	50	1		32/0	-20.24	30.4	-50.64	-13	37.64	H
Middle	29,439.99	50	1		32/0	-18.1	30.4	-48.5	-13	35.50	H

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
Middle	25,907.07	50	1	PUSCH DFT QPSK	32/0	-19.29	30.4	-49.69	-13	36.69	V
Middle	26,926.77	50	1		32/0	-19.25	30.4	-49.65	-13	36.65	V
Middle	27,084.78	50	1		32/0	-9.85	30.4	-40.25	-13	27.25	V
Middle	27,324.40	50	1		32/0	-19.26	30.4	-49.66	-13	36.66	V
Middle	28,923.39	50	1		32/0	-19.2	30.4	-49.6	-13	36.60	V
Middle	29,439.99	50	1		32/0	-16.93	30.4	-47.33	-13	34.33	V

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
high	27,084.78	50	1	PUSCH DFT QPSK	32/0	-7.67	30.4	-38.07	-13	25.07	H
high	28,360.48	50	1		32/0	-4.69	30.4	-35.09	-13	22.09	H
high	28,365.31	50	1		32/0	-6.19	30.4	-36.59	-13	23.59	H
high	28,370.61	50	1		32/0	-7.45	30.4	-37.85	-13	24.85	H
high	28,376.40	50	1		32/0	-8.56	30.4	-38.96	-13	25.96	H
high	28,381.71	50	1		32/0	-10.56	30.4	-40.96	-13	27.96	H

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
high	27,085.25	50	1	PUSCH DFT QPSK	32/0	-6.79	30.4	-37.19	-13	24.19	V
high	28,362.41	50	1		32/0	-1.18	30.4	-31.58	-13	18.58	V
high	28,368.20	50	1		32/0	-3.04	30.4	-33.44	-13	20.44	V
high	28,373.51	50	1		32/0	-3.67	30.4	-34.07	-13	21.07	V
high	28,379.29	50	1		32/0	-5.64	30.4	-36.04	-13	23.04	V
high	28,384.60	50	1		32/0	-7.64	30.4	-38.04	-13	25.04	V

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	26,470.77	100	1	PUSCH DFT QPSK	64/0	-11.11	30.4	-41.51	-13	28.51	H
low	27,034.01	100	1		64/0	-18.71	30.4	-49.11	-13	36.11	H
low	27,446.35	100	1		64/0	-5.52	30.4	-35.92	-13	22.92	H
low	27,474.82	100	1		64/0	-3.05	30.4	-33.45	-13	20.45	H
low	27,482.88	100	1		64/0	-2.54	30.4	-32.94	-13	19.94	H
low	28,723.21	100	1		64/0	-17.24	30.4	-47.64	-13	34.64	H

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	26,470.77	100	1	PUSCH DFT QPSK	64/0	-11.5	30.4	-41.9	-13	28.90	V
low	27,033.53	100	1		64/0	-17.06	30.4	-47.46	-13	34.46	V
low	27,454.89	100	1		64/0	-0.98	30.4	-31.38	-13	18.38	V
low	27,488.10	100	1		64/0	1.07	30.4	-29.33	-13	16.33	V
low	28,548.12	100	1		64/0	-19.83	30.4	-50.23	-13	37.23	V
low	28,723.21	100	1		64/0	-15.67	30.4	-46.07	-13	33.07	V

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
Middle	25,907.54	100	1	PUSCH DFT QPSK	64/0	-20.02	30.4	-50.42	-13	37.42	H
Middle	26,926.77	100	1		64/0	-19.81	30.4	-50.21	-13	37.21	H
Middle	27,085.25	100	1		64/0	-7.17	30.4	-37.57	-13	24.57	H
Middle	27,340.53	100	1		64/0	-19.8	30.4	-50.2	-13	37.20	H
Middle	28,851.04	100	1		64/0	-19.79	30.4	-50.19	-13	37.19	H
Middle	29,439.99	100	1		64/0	-16.18	30.4	-46.58	-13	33.58	H

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
Middle	25,907.54	100	1	PUSCH DFT QPSK	64/0	-18.68	30.4	-49.08	-13	36.08	V
Middle	26,926.77	100	1		64/0	-17.75	30.4	-48.15	-13	35.15	V
Middle	27,085.25	100	1		64/0	-6.7	30.4	-37.1	-13	24.10	V
Middle	27,301.15	100	1		64/0	-17.49	30.4	-47.89	-13	34.89	V
Middle	28,923.39	100	1		64/0	-17.73	30.4	-48.13	-13	35.13	V
Middle	29,439.99	100	1		64/0	-14.87	30.4	-45.27	-13	32.27	V

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
high	28,363.75	100	1	PUSCH DFT QPSK	64/0	-2.66	30.4	-33.06	-13	20.06	H
high	28,364.75	100	1		64/0	-3.67	30.4	-34.07	-13	21.07	H
high	28,368.25	100	1		64/0	-5.18	30.4	-35.58	-13	22.58	H
high	28,369.25	100	1		64/0	-5.32	30.4	-35.72	-13	22.72	H
high	28,370.25	100	1		64/0	-3.78	30.4	-34.18	-13	21.18	H
high	28,374.75	100	1		64/0	-4.44	30.4	-34.84	-13	21.84	H

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
high	25,990.11	100	1	PUSCH DFT QPSK	64/0	1.35	30.4	-29.05	-13	16.05	V
high	26,554.76	100	1		64/0	0.95	30.4	-29.45	-13	16.45	V
high	27,119.89	100	1		64/0	-0.01	30.4	-30.41	-13	17.41	V
high	28,360.00	100	1		64/0	-0.08	30.4	-30.48	-13	17.48	V
high	28,814.86	100	1		64/0	-0.2	30.4	-30.6	-13	17.60	V
high	29,379.69	100	1		64/0	-0.18	30.4	-30.58	-13	17.58	V

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	26,470.77	100	2	PUSCH DFT BPSK	64/0	-18.72	30.4	-49.12	-13	36.12	H
low	27,424.52	100	2		64/0	-16.09	30.4	-46.49	-13	33.49	H
low	27,446.82	100	2		64/0	-16.01	30.4	-46.41	-13	33.41	H
low	27,452.04	100	2		64/0	-16.46	30.4	-46.86	-13	33.86	H
low	27,474.82	100	2		64/0	-16.25	30.4	-46.65	-13	33.65	H
low	27,486.68	100	2		64/0	-15.59	30.4	-45.99	-13	32.99	H

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	26,470.77	100	2	PUSCH DFT BPSK	64/0	-18.04	30.4	-48.44	-13	35.44	V
low	27,410.28	100	2		64/0	-14.14	30.4	-44.54	-13	31.54	V
low	27,438.75	100	2		64/0	-13.9	30.4	-44.3	-13	31.30	V
low	27,466.28	100	2		64/0	-13.47	30.4	-43.87	-13	30.87	V
low	27,477.66	100	2		64/0	-13.52	30.4	-43.92	-13	30.92	V
low	27,488.58	100	2		64/0	-13.65	30.4	-44.05	-13	31.05	V

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
middle	25,991.53	100	2	PUSCH DFT BPSK	64/0	-26.77	30.4	-57.17	-13	44.17	H
middle	27,029.74	100	2		64/0	-25.45	30.4	-55.85	-13	42.85	H
middle	27,195.81	100	2		64/0	-17.59	30.4	-47.99	-13	34.99	H
middle	27,338.16	100	2		64/0	-25.19	30.4	-55.59	-13	42.59	H
middle	27,480.51	100	2		64/0	-25.26	30.4	-55.66	-13	42.66	H
middle	28,419.33	100	2		64/0	-23.27	30.4	-53.67	-13	40.67	H

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
middle	24,729.83	100	2	PUSCH DFT BPSK	64/0	-27.21	30.4	-57.61	-13	44.61	V
middle	25,907.54	100	2		64/0	-21.67	30.4	-52.07	-13	39.07	V
middle	26,496.40	100	2		64/0	-25.14	30.4	-55.54	-13	42.54	V
middle	27,084.78	100	2		64/0	-17.02	30.4	-47.42	-13	34.42	V
middle	28,848.62	100	2		64/0	-24.85	30.4	-55.25	-13	42.25	V
middle	29,439.99	100	2		64/0	-22.82	30.4	-53.22	-13	40.22	V

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
high	25,907.07	100	2	PUSCH DFT BPSK	64/0	-25.01	30.4	-55.41	-13	42.41	H
high	26,843.73	100	2		64/0	-25.4	30.4	-55.8	-13	42.80	H
high	27,084.78	100	2		64/0	-16.27	30.4	-46.67	-13	33.67	H
high	28,362.41	100	2		64/0	-23.21	30.4	-53.61	-13	40.61	H
high	28,851.04	100	2		64/0	-24.28	30.4	-54.68	-13	41.68	H
high	29,439.99	100	2		64/0	-22.48	30.4	-52.88	-13	39.88	H

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(MHz)	(MHz)				(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
high	24,729.83	100	2	PUSCH DFT BPSK	64/0	-26.63	30.4	-57.03	-13	44.03	V
high	25,907.07	100	2		64/0	-21.63	30.4	-52.03	-13	39.03	V
high	27,085.25	100	2		64/0	-16.04	30.4	-46.44	-13	33.44	V
high	27,443.50	100	2		64/0	-24.55	30.4	-54.95	-13	41.95	V
high	28,389.91	100	2		64/0	-20.95	30.4	-51.35	-13	38.35	V
high	29,439.99	100	2		64/0	-21.44	30.4	-51.84	-13	38.84	V

B.3 Frequency Stability

B.3.1 Summary

The frequency stability shall be measured by variation of ambient temperature and variation of primary supply voltage to ensure that the fundamental emission stays within the authorized frequency block.

B.3.2 Test Procedure

According to Clause 5.6 in ANSI C63.26-2015 and 2.1055

For temperature variation

1. Measure the carrier frequency at room temperature (20 °C to provide a reference)
2. At 10 °C intervals of temperatures between -30 °C and +50 °C
3. While maintaining a constant temperature inside the environmental chamber, turn on the EUT and allow sufficient time for the EUT temperature to stabilize

For supply voltage variation

1. The EUT was placed in a temperature chamber at 20 °C
2. The power is supplied by POE, and the test measured normal power only.

B.3.3 Measurement results

n261, QPSK

Frequency Error vs Temperature

OPERATING FREQUENCY: 27924960000Hz

POWER (VDC)	TEMP (°C)	Freq. Dev (Hz)	Relative Freq. Dev (Hz)
56	+20(REF)	14587.96	0
	-30	14772.3	184.34
	-20	14334.18	-253.78
	-10	14372.66	-215.3
	+0	14546.89	-41.07
	+10	14724.8	136.84
	+30	13113.27	-1474.69
	+40	14761.53	173.57
	+50	14304.61	-283.35

When the frequency stability limit is stated as being sufficient such that the fundamental emissions stay within the authorized bands of operation, a reference point shall be established at the applicable unwanted emissions limit using a RBW equal to the RBW required by the unwanted emissions specification of the applicable regulatory standard. These reference points measured using the lowest and highest channel of operation shall be identified as fL and fH respectively. The worst-case frequency offset determined in the above methods shall be added or subtracted from the values of fL and fH and the resulting frequencies must remain within the band.

The worst-case frequency offset is -1474.69Hz. The worst-case frequency offset added the values of fL and fH and the resulting frequencies are 27.550GHz and 28.299GHz. They remain within the



band 27.500GHz to 28.350GHz.

B.4 Occupied Bandwidth

B.4.1 Summary

occupied bandwidth (OBW) as the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean power is equal to 0.5% of the total mean power radiated by a given emission shall be measured.

No limit is applicable, the results are for reporting only.

B.4.2 Minimum Measurement Distance Evaluation

According to KDB842590 D01, the measurements of the fundamental emission, out of band, harmonics and spurious emissions shall be made in the far field of the measurement antenna. The

far-field boundary for mmW antennas is greater than or equal to $2D^2/\lambda$ (with D being the largest dimension of the antenna, and λ the wavelength of the emission). We calculate the far-field boundary and the test distance meet the requirement of standard.

For fundamental or out-of-band emissions the largest far-field distance of either the EUT antenna or measurement antenna shall be used. For spurious emissions the far-field distance will be based on the measurement antenna.

	Antenna	D(mm)	λ (mm)	far-field boundary (m)	Measurement distance(m)
18-40GHz	EUT mmW Antenna	33.65	16.8	0.37	3

B.4.3 Test Procedure

According to Clause 5.4 in ANSI C63.26-2015 and 2.1049

1. The spectrum analyzer center frequency is set to the nominal EUT channel center frequency. The frequency span for the spectrum analyzer shall be set wide enough to capture all modulation products including the emission skirts (typically a span of $1.5 \times$ OBW is sufficient).
2. Set RBW = 1% to 5% of the anticipated OBW
3. Set VBW $\geq 3 \times$ RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize

Test Note:

The average EIRP reported below is calculated by:

EIRP (dBm) = Spectrum Analyzer Channel Power Level(dBm) - Antenna Gain(dBi) + Cable Loss(dB) + $20\log(F)$ + $20\log(D)$ - 27.56

Where:

F: frequency (MHz)

D: Distance(m) = 3m

B.4.4 Measurement results

The plots are showed in Annex D.3.

Note: We choose the worst modulation by the power measured.

Module0, Beam ID: 26, 282

Band	Modulation	Channel	Bandwidth	CCs	OBW (MHz)	Pol.
261	CP-OFDM QPSK	middle	50	1	46.11	H
					46.24	V
261	CP-OFDM 16AQM	middle	50	1	46.05	H
					45.89	V
261	CP-OFDM 64AQM	middle	50	1	46.00	H
					46.12	V
261	CP-OFDM 256AQM	middle	50	1	46.07	H
					45.91	V

The high channel and low channel measure the OBW only with the worst modulation

Band	Modulation	Channel	Bandwidth	CCs	OBW (MHz)	Pol.
261	CP-OFDM QPSK	low	50	1	46.11	H
					46.10	V
261	CP-OFDM QPSK	high	50	1	46.17	H
					46.18	V

Module0, Beam ID: 26, 282

Band	Modulation	Channel	Bandwidth	CCs	OBW (MHz)	Pol.
261	DFT-s-OFDM PI/2 BPSK	middle	50	1	44.89	H
					46.08	V
261	DFT-s-OFDM QPSK	middle	50	1	46.22	H
					45.95	V
261	DFT-s-OFDM 16AQM	middle	50	1	44.76	H
					46.14	V
261	DFT-s-OFDM 64AQM	middle	50	1	44.87	H
					46.03	V
261	DFT-s-OFDM 256AQM	middle	50	1	44.11	H
					46.51	V

The high channel and low channel measure the OBW only with the worst modulation

Band	Modulation	Channel	Bandwidth	CCs	OBW (MHz)	Pol.
261	DFT-s-OFDM QPSK	low	50	1	44.91	H
					46.31	V
261	DFT-s-OFDM QPSK	high	50	1	44.91	H
					46.31	V

Module0, Beam ID: 26, 282

Band	Modulation	Channel	Bandwidth	CCs	OBW (MHz)	Pol.
261	CP-OFDM QPSK	middle	100	1	94.49	H
					94.47	V
261	CP-OFDM 16AQM	middle	100	1	94.21	H
					94.09	V
261	CP-OFDM 64AQM	middle	100	1	94.20	H
					94.17	V
261	CP-OFDM 256AQM	middle	100	1	94.42	H
					94.18	V

The high channel and low channel measure the OBW only with the worst modulation

Band	Modulation	Channel	Bandwidth	CCs	OBW (MHz)	Pol.
261	CP-OFDM QPSK	low	100	1	94.34	H
					94.29	V
261	CP-OFDM QPSK	high	100	1	94.38	H
					94.50	V

Module0, Beam ID: 26, 282

Band	Modulation	Channel	Bandwidth	CCs	OBW (MHz)	Pol.
261	DFT-s-OFDM PI/2 BPSK	middle	100	1	90.27	H
					91.54	V
261	DFT-s-OFDM QPSK	middle	100	1	90.37	H
					92.00	V
261	DFT-s-OFDM 16AQM	middle	100	1	91.99	H
					90.98	V
261	DFT-s-OFDM 64AQM	middle	100	1	90.10	H
					91.69	V
261	DFT-s-OFDM 256AQM	middle	100	1	91.76	H
					90.57	V

The high channel and low channel measure the OBW only with the worst modulation

Band	Modulation	Channel	Bandwidth	CCs	OBW (MHz)	Pol.
261	DFT-s-OFDM QPSK	low	100	1	90.60	H
					91.70	V
261	DFT-s-OFDM QPSK	high	100	1	90.60	H
					91.70	V

Module0, Beam ID: 26, 282

Band	Modulation	Channel	Bandwidth	CCs	OBW (MHz)	Pol.
261	CP-OFDM QPSK	middle	100	2	192.92	H
					193.47	V
261	CP-OFDM 16AQM	middle	100	2	193.46	H
					193.12	V
261	CP-OFDM 64AQM	middle	100	2	193.29	H
					193.20	V
261	CP-OFDM 256AQM	middle	100	2	192.89	H
					193.62	V

The high channel and low channel measure the OBW only with the worst modulation

Band	Modulation	Channel	Bandwidth	CCs	OBW (MHz)	Pol.
261	CP-OFDM QPSK	low	100	2	193.50	H
					193.44	V
261	CP-OFDM QPSK	high	100	2	193.51	H
					193.25	V

Module0, Beam ID: 26, 282

Band	Modulation	Channel	Bandwidth	CCs	OBW (MHz)	Pol.
261	DFT-s-OFDM PI/2 BPSK	middle	100	2	191.11	H
					189.59	V
261	DFT-s-OFDM QPSK	middle	100	2	191.27	H
					190.09	V
261	DFT-s-OFDM 16AQM	middle	100	2	191.00	H
					190.07	V
261	DFT-s-OFDM 64AQM	middle	100	2	190.87	H
					189.20	V
261	DFT-s-OFDM 256AQM	middle	100	2	190.34	H
					189.15	V

The high channel and low channel measure the OBW only with the worst modulation

Band	Modulation	Channel	Bandwidth	CCs	OBW (MHz)	Pol.
261	DFT-s-OFDM PI/2 BPSK	low	100	2	191.02	H
					189.36	V
261	DFT-s-OFDM PI/2 BPSK	high	100	2	190.90	H
					189.83	V

The module1 (beam ID: 30, 286) measure the EIRP only with the worst modulation.
 Module1, Beam ID: 30, 286

Band	Modulation	Channel	Bandwidth	CCs	OBW (MHz)	Pol.
261	DFT-S-OFDM QPSK	low	50	1	44.94	H
					46.31	V
261	DFT-S-OFDM QPSK	middle	50	1	44.57	H
					46.15	V
261	DFT-S-OFDM QPSK	high	50	1	44.94	H
					46.10	V

Band	Modulation	Channel	Bandwidth	CCs	OBW (MHz)	Pol.
261	DFT-S-OFDM QPSK	low	100	1	91.67	H
					91.50	V
261	DFT-S-OFDM QPSK	middle	100	1	90.17	H
					91.93	V
261	DFT-S-OFDM QPSK	high	100	1	91.85	H
					89.51	V

Band	Modulation	Channel	Bandwidth	CCs	OBW (MHz)	Pol.
261	DFT-s-OFDM PI/2 BPSK	low	100	2	190.54	H
					190.89	V
261	DFT-s-OFDM PI/2 BPSK	middle	100	2	191.08	H
					189.04	V
261	DFT-s-OFDM PI/2 BPSK	high	100	2	191.00	H
					188.54	V

B.5 Band Edge Compliance

B.5.1 Summary

All modes of operation were investigated and the worst case configuration results are reported in this section.

30.203 (a) The conductive power or the total radiated power of any emission outside a licensee's frequency block shall be -13dBm/MHz or lower. However, in the bands immediately outside and adjacent to the licensee's frequency block, having a bandwidth equal to 10 percent of the channel bandwidth, the conductive power or the total radiated power of any emission shall be -5 dBm/MHz or lower.

B.5.2 Minimum Measurement Distance Evaluation

According to KDB842590 D01, the measurements of the fundamental emission, out of band, harmonics and spurious emissions shall be made in the far field of the measurement antenna. The

far-field boundary for mmW antennas is greater than or equal to $2D^2/\lambda$ (with D being the largest dimension of the antenna, and λ the wavelength of the emission). We calculate the far-field boundary and the test distance meet the requirement of standard.

For fundamental or out-of-band emissions the largest far-field distance of either the EUT antenna or measurement antenna shall be used. For spurious emissions the far-field distance will be based on the measurement antenna.

	Antenna	D(mm)	λ (mm)	far-field boundary (m)	Measurement distance(m)
18-40GHz	EUT mmW Antenna	33.65	16.8	0.37	3

B.5.3 Test Procedure

According to Clause 5.7 in ANSI C63.26-2015 and Clause 4.4 in KDB 842590 D01 v01r02

1. Start and stop frequency were set such that both upper and lower band edges are measured.
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. Set RBW=1MHz, VBW=3MHz
4. Set number of measurement points in sweep $\geq 2 \times \text{span}/\text{RBW}$
5. Set Detector = RMS
6. Set Sweep time = auto-couple
7. Trace average at least 100 traces in power averaging (rms) mode
8. The trace was allowed to stabilize

Test Note:

According to 4.4.2.5 in KDB 842590 D01 v01r02, the conducted power is calculated by:

Conducted Power Level (dBm) at any frequency/BW = Measured EIRP (dBm)/BW – EUT antenna Gain (dBi)

The average EIRP reported below is calculated by:

EIRP (dBm) = Spectrum Analyzer Level (dBm) - Antenna Gain (dBi) + Cable Loss (dB) + 20log (F)



+ 20log(D) - 27.56

Where: F: frequency (MHz), D: Distance(m)

B.5.4 Measurement result

n261

Note: The measured EIRP levels are below the TRP limit and the early exit condition is met.

Note: The channel with the maximum power was chosen.

Module0, Beam ID: 26, 282

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(GHz)	(MHz)		(GHz)		(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	27.500	50	1	CP-OFDM QPSK	32/0	3.09	30.4	-27.31	-5	22.31	H
low	27.500	50	1		32/0	0.75	30.4	-29.65	-5	24.65	V
low	27.490	50	1		32/0	0.28	30.4	-30.12	-13	17.12	H
low	27.490	50	1		32/0	-0.05	30.4	-30.45	-13	17.45	V
high	28.350	50	1	CP-OFDM QPSK	32/0	2.84	30.4	-27.56	-5	22.56	H
high	28.350	50	1		32/0	2.1	30.4	-28.3	-5	23.30	V
high	28.360	50	1		32/0	1.01	30.4	-29.39	-13	16.39	H
high	28.360	50	1		32/0	0.12	30.4	-30.28	-13	17.28	V

Module0, Beam ID: 26, 282

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(GHz)	(MHz)		(GHz)		(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	27.500	50	1	CP-OFDM QPSK	1/0	-6.75	30.4	-37.15	-5	32.15	H
low	27.500	50	1		1/0	-5.99	30.4	-36.39	-5	31.39	V
low	27.495	50	1		1/0	-17.05	30.4	-47.45	-13	34.45	H
low	27.495	50	1		1/0	-16.8	30.4	-47.2	-13	34.20	V
high	28.350	50	1	CP-OFDM QPSK	1/31	-7.84	30.4	-38.24	-5	33.24	H
high	28.350	50	1		1/31	-6.84	30.4	-37.24	-5	32.24	V
high	28.355	50	1		1/31	-16.71	30.4	-47.11	-13	34.11	H
high	28.355	50	1		1/31	-15.94	30.4	-46.34	-13	33.34	V

Module0, Beam ID: 26, 282

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(GHz)	(MHz)		(GHz)		(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	27.500	50	1	DFT-S-OFDM QPSK	32/0	2.48	30.4	-27.92	-5	22.92	H
low	27.497	50	1		32/0	1.39	30.4	-29.01	-5	24.01	V
low	27.489	50	1		32/0	-0.02	30.4	-30.42	-13	17.42	H
low	27.486	50	1		32/0	-2.07	30.4	-32.47	-13	19.47	V
high	28.350	50	1	DFT-S-OFDM QPSK	32/0	2.79	30.4	-27.61	-5	22.61	H
high	28.350	50	1		32/0	3.75	30.4	-26.65	-5	21.65	V
high	28.355	50	1		32/0	1.32	30.4	-29.08	-13	16.08	H
high	28.355	50	1		32/0	2.24	30.4	-28.16	-13	15.16	V

Module0, Beam ID: 26, 282

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(GHz)	(MHz)		(GHz)		(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	27.500	50	1	DFT-S-OFDM BPSK	1/0	-0.41	30.4	-30.81	-5	25.81	H
low	27.500	50	1		1/0	-1.5	30.4	-31.9	-5	26.90	V
low	27.495	50	1		1/0	-15.59	30.4	-45.99	-13	32.99	H
low	27.495	50	1		1/0	-16.53	30.4	-46.93	-13	33.93	V
high	28.350	50	1	DFT-S-OFDM BPSK	1/31	-12.22	30.4	-42.62	-5	37.62	H
high	28.350	50	1		1/31	-6.52	30.4	-36.92	-5	31.92	V
high	28.355	50	1		1/31	-20	30.4	-50.4	-13	37.40	H
high	28.355	50	1		1/31	-14.84	30.4	-45.24	-13	32.24	V

Module0, Beam ID: 26, 282

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(GHz)	(MHz)		(GHz)		(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	27.500	100	1	CP-OFDM QPSK	66/0	1.63	30.4	-28.77	-5	23.77	H
low	27.500	100	1		66/0	2.41	30.4	-27.99	-5	22.99	V
low	27.490	100	1		66/0	0.02	30.4	-30.38	-13	17.38	H
low	27.490	100	1		66/0	0.11	30.4	-30.29	-13	17.29	V
high	28.350	100	1	CP-OFDM QPSK	66/0	1.25	30.4	-29.15	-5	24.15	H
high	28.350	100	1		66/0	0.79	30.4	-29.61	-5	24.61	V
high	28.360	100	1		66/0	0.17	30.4	-30.23	-13	17.23	H
high	28.360	100	1		66/0	0.34	30.4	-30.06	-13	17.06	V

Module0, Beam ID: 26, 282

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(GHz)	(MHz)		(GHz)		(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	27.500	100	1	CP-OFDM 64QAM	1/0	-8.05	30.4	-38.45	-5	33.45	H
low	27.500	100	1		1/0	-7.81	30.4	-38.21	-5	33.21	V
low	27.490	100	1		1/0	-21.39	30.4	-51.79	-13	38.79	H
low	37.490	100	1		1/0	-21.75	30.4	-52.15	-13	39.15	V
high	28.350	100	1	CP-OFDM 64QAM	1/65	-9.1	30.4	-39.5	-5	34.50	H
high	28.350	100	1		1/65	-9.07	30.4	-39.47	-5	34.47	V
high	28.360	100	1		1/65	-21.06	30.4	-51.46	-13	38.46	H
high	28.360	100	1		1/65	-20.99	30.4	-51.39	-13	38.39	V

Module0, Beam ID: 26, 282

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.	
	(GHz)	(MHz)		(GHz)		(dBm)	(dBi)	(dBm)	(dBm)	(dB)		
low	27.498	100	1	DFT-S-OFDM QPSK	64/0	-8.7	30.4	-39.1	-5	34.10	H	
low	27.500	100	1		64/0	-4.77	30.4	-35.17	-5	30.17	V	
low	27.487	100	1		64/0	-10.85	30.4	-41.25	-13	28.25	H	
low	27.490	100	1		64/0	-4.52	30.4	-34.92	-13	21.92	V	
high	28.352	100	1		64/0	2.07	30.4	-28.33	-5	23.33	H	
high	28.355	100	1		DFT-S-OFDM QPSK	64/0	0.14	30.4	-30.26	-5	25.26	V
high	28.362	100	1		64/0	0.67	30.4	-29.73	-13	16.73	H	
high	28.365	100	1		64/0	-0.78	30.4	-31.18	-13	18.18	V	

Module0, Beam ID: 26, 282

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(GHz)	(MHz)		(GHz)		(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	27.500	100	1	DFT-S-OFDM QPSK	1/0	-3.64	30.4	-34.04	-5	29.04	H
low	27.500	100	1		1/0	-10.77	30.4	-41.17	-5	36.17	V
low	27.490	100	1		1/0	-18.79	30.4	-49.19	-13	36.19	H
low	37.490	100	1		1/0	-23.68	30.4	-54.08	-13	41.08	V
high	28.350	100	1	DFT-S-OFDM QPSK	1/63	-11.49	30.4	-41.89	-5	36.89	H
high	28.350	100	1		1/63	-20.05	30.4	-50.45	-5	45.45	V
high	28.360	100	1		1/63	-20.31	30.4	-50.71	-13	37.71	H
high	28.360	100	1		1/63	-24.33	30.4	-54.73	-13	41.73	V

Module0, Beam ID: 26, 282

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(GHz)	(MHz)		(GHz)		(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	27.500	100	2	CP-OFDM QPSK	66/0	-8.17	30.4	-38.57	-5	33.57	H
low	27.500	100	2		66/0	-9.98	30.4	-40.38	-5	35.38	V
low	27.490	100	2		66/0	-8.83	30.4	-39.23	-13	26.23	H
low	27.490	100	2		66/0	-11.01	30.4	-41.41	-13	28.41	V
high	28.350	100	2	CP-OFDM QPSK	66/0	-8.55	30.4	-38.95	-5	33.95	H
high	28.350	100	2		66/0	-8.39	30.4	-38.79	-5	33.79	V
high	28.360	100	2		66/0	-10.33	30.4	-40.73	-13	27.73	H
high	28.360	100	2		66/0	-10.71	30.4	-41.11	-13	28.11	V

Module0, Beam ID: 26, 282

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(GHz)	(MHz)		(GHz)		(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	27.500	100	2	CP-OFDM 64QAM	1/0	-11.04	30.4	-41.44	-5	36.44	H
low	27.500	100	2		1/0	-11.68	30.4	-42.08	-5	37.08	V
low	27.490	100	2		1/0	-23.07	30.4	-53.47	-13	40.47	H
low	37.490	100	2		1/0	-23	30.4	-53.4	-13	40.40	V
high	28.350	100	2	CP-OFDM 64QAM	1/65	-10.61	30.4	-41.01	-5	36.01	H
high	28.350	100	2		1/65	-9.26	30.4	-39.66	-5	34.66	V
high	28.360	100	2		1/65	-21.25	30.4	-51.65	-13	38.65	H
high	28.360	100	2		1/65	-20.63	30.4	-51.03	-13	38.03	V

Module0, Beam ID: 26, 282

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.	
	(GHz)	(MHz)		(GHz)		(dBm)	(dBi)	(dBm)	(dBm)	(dB)		
low	27.497	100	2	DFT-S-OFDM BPSK	64/0	-4.21	30.4	-34.61	-5	29.61	H	
low	27.500	100	2		64/0	-1.69	30.4	-32.09	-5	27.09	V	
low	27.485	100	2		64/0	-4.63	30.4	-35.03	-13	22.03	H	
low	37.482	100	2		64/0	-2.73	30.4	-33.13	-13	20.13	V	
high	28.353	100	2		64/0	-5.83	30.4	-36.23	-5	31.23	H	
high	28.350	100	2		DFT-S-OFDM BPSK	64/0	-4.41	30.4	-34.81	-5	29.81	V
high	28.364	100	2		64/0	-6.36	30.4	-36.76	-13	23.76	H	
high	28.362	100	2		64/0	-5.14	30.4	-35.54	-13	22.54	V	

Module0, Beam ID: 26, 282

Channel	Freq.	BW	CCs	Modulation	RB	Avg EIRP	Antenna Gain	Conduct EIRP	Conduct EIRP Limit	Margin	Pol.
	(GHz)	(MHz)		(GHz)		(dBm)	(dBi)	(dBm)	(dBm)	(dB)	
low	27.500	100	2	DFT-S-OFDM 16QAM	1/0	-7.95	30.4	-38.35	-5	33.35	H
low	27.500	100	2		1/0	-15.67	30.4	-46.07	-5	41.07	V
low	27.490	100	2		1/0	-21.86	30.4	-52.26	-13	39.26	H
low	27.490	100	2		1/0	-23.72	30.4	-54.12	-13	41.12	V
high	28.350	100	2	DFT-S-OFDM 16QAM	1/63	-17.56	30.4	-47.96	-5	42.96	H
high	28.350	100	2		1/63	-17.3	30.4	-47.7	-5	42.70	V
high	28.360	100	2		1/63	-21.94	30.4	-52.34	-13	39.34	H
high	28.360	100	2		1/63	-22.14	30.4	-52.54	-13	39.54	V